

"stri, fästri aufi rgerener utendi faser setter" - finereget al. arget med Stri Swami Vivekanand Shikshan Sanstha, Kolhapur. VIVEKANAND COLLEGE, KOLHAPUR (Autonomous)

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Chemical vapour deposition By Dr. Inamdar Sumayya Isak_{M.Sc., Ph.D.} (Assit.Professor) DEPARTMENT OF PHYSICS

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Introduction:

- * "Chemical vapour deposition (CVD) is a process where one or more volatile precursors are transported via the vapour phase to the reaction chamber, where they decompose on a heated substrate"
- Many materials may be deposited using CVD and related techniques. Metals, oxides, sulfides, nitrides, phosphides, arsenides, carbides, borides, silicides...

Example: Preparation of TiB₂, melting point 3325°C. May be deposited by CVD at 1000°C:

 $\text{TiCl}_4 + 2\text{BCl}_3 + 5\text{H}_2 \rightarrow \text{TiB}_2 + 10 \text{ HCl}$

> CVD was first used for hard coatings (cutting tools etc.)

Microelectronics, 3D-structures

Glass (SnO₂, TiN, SiO₂, TiO₂)

Solar cells, catalysis, membranes, waveguides, mirrors, "synthetic gold" (TiN_x)

Classification of CVD

- According to the activation process it is classified as:
- 1. Thermal CVD: heat energy for activation of the required gas and gas-solid phase reactions.
 - a. atmospheric pressure CVD- APCVD
 - b. low pressure CVD-LPCVD
 - c. metal organic CVD-MOCVD
- Plasma enhanced CVD- plasma activation of the chemical species.
 a. plasma enhanced CVD- PECVD

CVD reaction type:

- > Pyrolysis
- ➤ Reduction
- ➤ Oxidation
- Compound formation
- Disproportionation
- Reversible transfer

1. Pyrolysis: Thermochemical decomposition of organic material at elevated temperature in the absence of oxygen.

$$\begin{array}{c} \underset{Silane}{\text{Silane}}{} \xrightarrow{\text{amorphous}}{} Si_{(s)} + 2H_{2(g)} & (650 \ ^{\circ}\text{C}) \\ & & \\$$

2. Reduction: any process in which electrons are added to an atom or ion (as by removing oxygen or adding hydrogen); always occurs accompanied by oxidation of the reducing agent

$$\begin{aligned} & \underset{(g)}{\text{siCl}_{4(g)}} + 2H_{2(g)} \xrightarrow{\text{opitaxial}} Si \underset{(s)}{\overset{(g)}{\rightarrow}} 4HCl_{(g)} & (1200^{\circ}\text{C}) \end{aligned}$$
$$WF_{6(g)} + 3H_{2(g)} \xrightarrow{\text{opitaxial}} W_{(s)} + 6HF_{(g)} & (300^{\circ}\text{C}) \end{aligned}$$
$$MoF_{6(g)} + 3H_{2(g)} \xrightarrow{\text{opitaxial}} Mo_{(s)} + 6HF_{(g)} & (300^{\circ}\text{C}) \end{aligned}$$

3. Oxidation: is any electrochemical process which involves the formal oxidation state of an atom or atoms (within a molecule) being increased by the removal of electrons (loss of electron). E.g. iron(II) can be oxidized to iron(III):

Silane

$$SiH_{4(g)} + O_{2(g)} \rightarrow SiO_{2(s)} + 2H_{2(g)} \qquad (450 \ ^{\circ}C)$$

$$2AlCl_{3(g)} + 3H_{2(g)} + 3CO_{2(g)} \rightarrow$$

$$\rightarrow Al_2O_{3(s)} + 3CO_{(g)} + 6HCl_{(g)} \qquad (1000 \ ^{\circ}C)$$

4. Compound formation: a variety of carbide, nitride films and coatings can be readily produced by CVD techniques. The requirement is that both compound element are exist in volatile form and be reactive in gasses form.

$$SiCl_{4(g)} + CH_{4(g)} \rightarrow SiC_{(s)} + 4HCl_{(g)} \qquad (1400^{\circ}C)$$
$$TiCl_{4(g)} + CH_{4(g)} \rightarrow TiC_{(s)} + 4HCl_{(g)} \qquad (1000^{\circ}C)$$
$$BF_{3(g)} + NH_{3(g)} \rightarrow BN_{(s)} + 3HF_{(g)} \qquad (1100^{\circ}C)$$

5. Disproportion : Disproportionation reactions are possible when a nonvolatile metal can form volatile compounds having different degrees of stability, depending on the temperature. This happens when the metal is two valance state.

So it a chemical reaction in which a single substance acts as both oxidizing and reducing agent, resulting in the production of dissimilar substances

$$300 \text{ C}$$

$$2\text{GeI}_{2(g)} \longleftrightarrow \text{Ge}_{(s)} + \text{GeI}_{4(g)}$$

$$600 \text{ C}$$

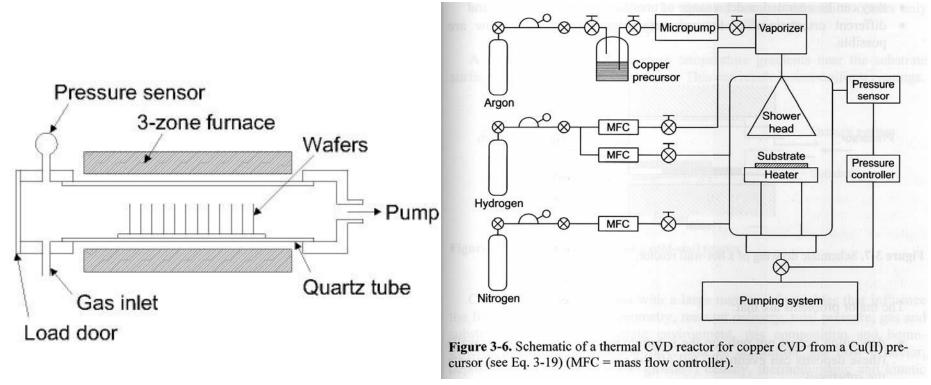
Al, B, Ga, In, Si, Ti, Zr, Be, Cr can be deposited this way

5. Reversible transfer: Chemical transfer or transport processes are characterized by a reversal in the reaction equilibrium at source and deposition regions maintained at different temperatures within a single reactor.

An important example is the deposition of single-crystal (epitaxial) GaAs films by the chloride process according to the reaction

 $As_{4(g)} + As_{2(g)} + 6GaCl_{(g)} + 3H_{2(g)} \underset{_{850\,^{\circ}C}}{\longleftrightarrow} 6GaAs_{(s)} + 6HCl_{(g)}$

Instrumentation of CVD:



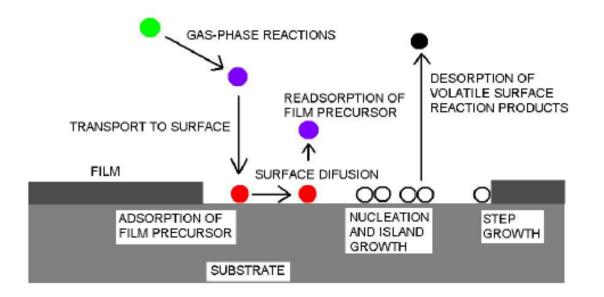
- 1. Carrier gas inlet with pressure control: with the help of carrier gas precursor will be inserted into reaction chamber.
- 2. Deposition (reaction) chamber: temperature controlled deposition chamber.
- 3. Proper exhaust: output gas is to be exhausted in the environment.

CVD – Chemical Vapor Deposition

The fundamental sequential steps of CVD process:

- Transport of reactants to the reaction zone.
 Chemical reactions in the gas phase.
 Transport of reactants and their products to the substrate.
 - 4. Adsorption and diffusion on the substrate surface.
 - 5. Heterogeneous reactions catalyzed by the surface leading to film formation.
 - 6. Desorption of the volatile by-products of surface reactions.







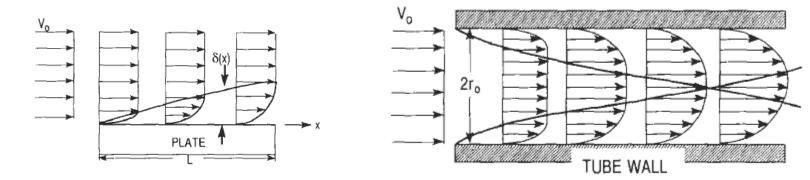
The ideal precursor

- Liquid rather than solid or gaseous
- Good volatility
- Good thermal stability in the delivery system, during evaporation and transport
- Decompose cleanly and controllably on the substrate without incorporation
- Give stable by-products which are readily removed from the reaction zone
- Readily available in consistent quality and quantity at low cost
- Non-toxic and non-pyrophoric

Gas Transport:

It is process by which volatile precursor or species flow from one part of the reactor to another. It is important to know because;

- Film thickness and uniformity highly dependent on the delivery of equal amount of reactant to all substrate surface.
- Deposition growth rate also dependent on the optimized flow rate
- Efficient utilization of process gases.
- 1. Viscous flow: The viscous flow region is operative when gas transport occurs at pressure of roughly 0.01 atm and above in a reactor.
- flow velocity has uniform value v₀, but only prior to impinging to leading edge of the plate, however flow progresses velocity of gradients, which form because the gas clings to the plate.



2. **Diffusion:** The diffusion is the phenomenon occurs in gases and liquids as well as in solids. If two different gases are initially separated and then allowed to mix, each will move from regions of higher to lower concentration. This process is known as diffusion.

According to Kinetic theory of gasses

Diffusion (D) \sim T^{3/2}/P depends on temperature on pressure.

$$D = D_0 \frac{P_0}{P} \left(\frac{T}{T_0}\right)^n,$$

Where,

 D_0 -value of D measured at standard temperature T_0 (273 k)

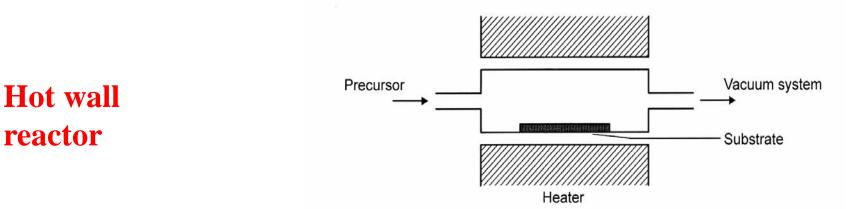
 P_0 - pressure (1 atm) depends on gas combination in question.

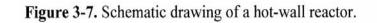
Generally the value of D_0 at temperatures of interest span is in the range 0.1-10 cm²/sec and many orders of magnitude higher in case of diffused solids. 3. **Convection:** convection is a bulk gas flow process that can be distinguished from both diffusion and viscous flow.

- diffusion involves statistical motion of atoms and molecules driven by concentration gradient.
- Convection arises from the response to gravitational, centrifugal, electric, and magnetic forces.

Reactor: There are two type of reactor

- 1. hot wall reactor
- 2. cold wall reactor.





Advantages:

- •Simple to operate
- •May accommodate several substrate.
- •Uniform substrate temperature
- •May be operated at a range of temperatures and pressures
- •Different orientations of substrate

Disadvantages:

•Deposition occur not only at the substrate, but also on edges of reactor walls.

•The consumption of precursor is large and difficult to control. May result in feed-rate-limited deposition

•Gas-phase reactions may occur

Cold wall reactor

Substrate is at a higher temperature than the reactor walls. Often used in industry

Advantages:

•Pressure and temperature can be controlled

•Plasmas can be used

•No deposition on reactor walls

•Gas-phase reactions are suppressed

•Higher deposition rates may be reached (higher precursor efficiency

Disadvantages:

Steep temperature gradients near the substrate surface may lead to convectionLess flexibility on substrate orientation and usually only one substrate at a time.

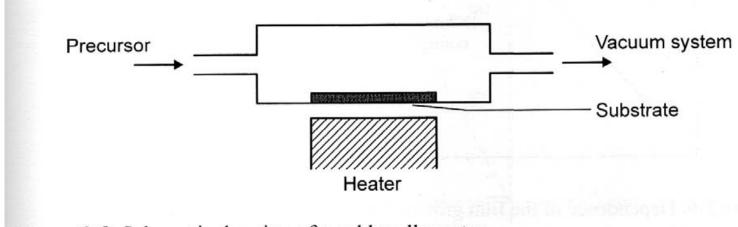


Figure 3-8. Schematic drawing of a cold-wall reactor.

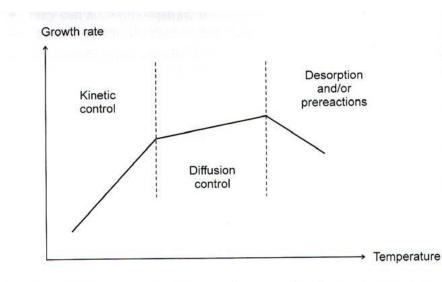
Growth kinetics:

Growth kinetics in CVD depends on several parameters;

- 1. Transport of reactants through the boundary layer to the substrate
- 2. Adsorption of reactants at the substrate
- 3. Atomic and molecular surface diffusion, chemical reactions, and incorporation into the lattice.
- 4. Transport of the byproduct away from the substrate through boundary layer

- The growth rate uniformity is part of growth kinetics, which depends on;
 - 1. The gas has a constant velocity component along the axis tube.
 - 2. The whole system is at constant temperature.
 - 3. The reactor extends a large distance in the z direction so that the problem reduces to one of two dimension.

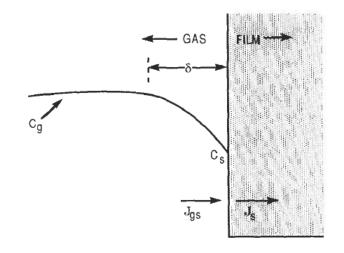
• **Temperature dependence;** growth kinetics is temperature dependent and which separates into three regimes.



Three regimes:Surface reaction (kinetically) limited.Diffusion (or mass transport) limited.Increased desorption rate of precursors.

Figure 3-9. Dependence of the film growth rate on the substrate temperature.

According to Groves model of kinetics of film growth is temperature dependent



 A drop in concentration of reactant from Cg in bulk gas to Cs at the interface and it increases with the temperature hence growth rate limits even the bulk gas concentration is enough to deposit.

CVD Processes and system:

1. Low temperature systems:

in case of fabrication of Si bipolar and MOS integrated circuit there is important need to deposit thin film of SiO_2 , phosphosilicate and borophosphosilicate glasses and silicon nitrite films for different purposes but it has upper temperature limit to tolerate is 450 0C because aluminum metallization used for device contacts and interconnection begins to react with Si beyond this temperature.

several type of atmospheric pressure CVD reactors are designed for such type of insulating film deposition.

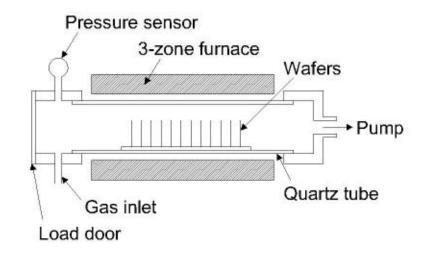
2. High temperature systems:

there is need to reduce the semiconductor processing temperature but the growth of high quality epitaxial thin films can be achieved at high temperature CVD methods.

- This is true of Si as well deposition of some type of compound semiconductors.
- High temperature ATM pressure system is extensively employed for metallurgical coating operation.
- cold wall reactor systems are extensively used for epitaxial Si films

Low pressure CVD: (LPCVD)

• Historically it is first employed to deposit polysilicon films with greater control over stoichiometry and contamination problem.



- Gas pressure range- 0.5 to 1 torr.
- To compensate for the low pressure, the input reactant gas concentration has to increase relative to the atmospheric reactor case.
- Diffusivity is 1000 times higher than the APCVD.

Advantages: high deposition rate, improved film thickness uniformity, better step coverage, lower particle density etc are the important advantages relative to atmospheric CVD processing.

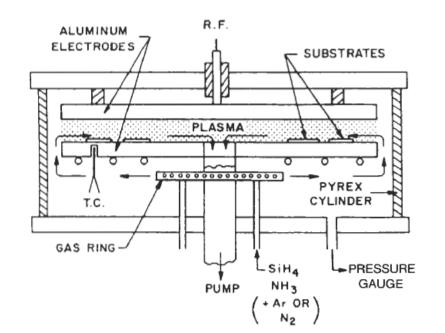
Plasma enhanced CVD: (PECVD)

- Wherein glow discharge plasma is sustained within the chambers where the simultaneous CVD reactions occurs. It is same as LPCVD.
- Radio frequency range 100kHz to 40 MHz

gas pressure – 50mtorr to 5 torr

at this condition electron and positive ion density number ranges between 10⁹ to 10¹²/ cm³ and average electron energy range from 1 to 10eV. This energetic discharge is sufficient to decompose gas molecules into variety of component species.

• So the net effect of interaction cause chemical reactions to occurs at much lower temperature than convectional CVD.



- The major commercial application of this technique is to deposit a silicon nitrate films.
- The deposition is takes place at low pressure and growth rate is around 300 A/min.
- Some elements e.g. carbon, boron, in addition to metals, oxides, nitrides and silicides has been deposited by using this technique.

| Deposit | T (K) | Rate (cm/sec) | Reactants SiH ₄ ; SiF ₄ -H ₂ ; Si(s)-H ₂ | |
|------------------------------------|-----------|------------------------------------|---|--|
| a-Si | 573 | 10-8-10-7 | | |
| c-Si | 673 | 10 ⁻⁸ -10 ⁻⁷ | SiH4-H2; SiF4-H2; Si(s)-H2 | |
| a-Gc | 673 | 10 ⁻⁸ ~10 ⁻⁷ | GeH4 | |
| c-Ge | 673 | 10-8-10-7 | GeH ₄ -H ₂ ; Ge(s)-H ₂ | |
| a-B | 673 | $10^{-8} - 10^{-7}$ | B2H6; BCl3-H2; BBr3 | |
| a-P. c-P | 293-473 | 10 - 5 | P(s)-H ₂ | |
| As | < 373 | 10-6 | AsH3; As(s)-H2 | |
| Se, Te, Sb, Bi | 373 | 10-7-10-6 | Me-H ₂ | |
| Mo | | | Mo(CO) ₄ | |
| Ni | | | Ni(CO) ₄ | |
| C (graphite) | 1073-1273 | 10-5 | $C(s)-H_2$; $C(s)-N_2$ | |
| CdS | 373-573 | 10-6 | Cd-H ₂ S | |
| Oxides | | | _ | |
| SiO ₂ | 523 | 10-8-10-6 | Si(OC2H3)4; SiH4-O2, N2O | |
| GeO ₂ | 523 | $10^{-8} - 10^{-6}$ | Ge(OC 2H 5)4; GeH4-O2, N2C | |
| SiO ₂ /GeO ₂ | 1273 | 3×10^{-4} | $SiCl_4-GeCl_4 + O_2$ | |
| Al ₂ O ₃ | 523-773 | 10-8-10-7 | AICI3-O2 | |
| TiO ₂ | 473-673 | 10-8 | TiCl4-O2; metallorganics | |
| B ₂ O ₃ | | | B(OC ₂ H ₅) ₅ -O ₂ | |
| Nitrides | | | | |
| Si ₃ N ₄ (H) | 573-773 | $10^{-8} \sim 10^{-7}$ | SiH ₄ -N ₂ , NH ₃ | |
| AIN | 1273 | 10-6 | AICI ₃ -N ₂ | |
| GaN | 873 | 10-8-10-7 | GaCl ₃ -N ₂ | |
| TiN | 523-1273 | $10^{-8} - 5 \times 10^{-5}$ | $TiCl_4-H_2 + N_2$ | |
| BN | 673-973 | | B ₂ H ₆ -NH ₃ | |
| P ₃ N ₃ | 633-673 | 5×10^{-6} | P(s)-N2; PH3-N2 | |
| Carbides | | | | |
| SiC | 473-773 | 10-8 | SiH ₄ -C _n H _m | |
| TiC | 673-873 | $5 \times 10^{-8} - 10^{-6}$ | $TiCl_4-CH_4 + H_2$ | |
| B,C | 673 | $10^{-8} - 10^{-7}$ | B ₂ H ₆ -CH ₆ | |

Table 4-4. PECVD Reactants and Products, Deposition Temperatures, and Rates

Different materials deposited by PECVD

Metal organic CVD: (MOCVD)

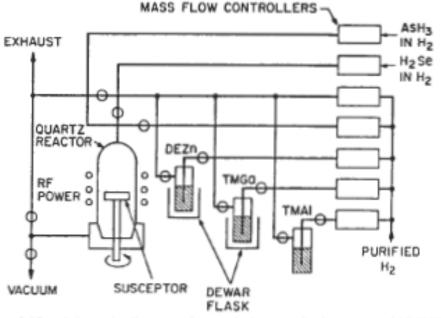
- It is differ from the conventional CVD on the basis of chemical nature of the precursor gasses.
- As a name metal organic trimethyl gallium (TMGa), Trimethyl-indium(TMIn) etc are used. They are reacted with group V hydrides.

 $(CH_3)_3Ga_{(g)} + AsH_{3(g)} \rightarrow GaAs_{(s)} + 3CH_{4(g)}$

Advantage:

• The great advantage of this type of precursor is that they are volatile at moderately low temperature.





| Compound | | Vapor Pressure* of OM precursor | | Growth Temperature |
|----------|--------------------------|------------------------------------|------|--------------------|
| | Reactants | a | b | ('C) |
| AlAs | TMAI + AsH ₃ | 8.224 | 2135 | 700 |
| AIN | TMAI + NH ₃ | | | 1250 |
| GaAs | TMGa + AsH ₃ | 8.50 | 1824 | 650~750 |
| GaN | TMGa + NH ₃ | | | 800 |
| GaP | TMGa + PH, | | | 750 |
| GaSb | TEGa + TMSb | 9.17 | 2532 | 500-550 |
| | | 7.73 | 1709 | |
| InAs | TEIn + AsH ₃ | | | 650-700 |
| InP | TEIn + PH ₃ | | | 725 |
| ZnS | DEZn + H ₂ S | 8.28 | 2190 | |
| ZnSe | DEZn + H ₂ Se | | | |
| CdS | DMCd + H ₂ S | 7.76 | 1850 | |
| HgCdTe | Hg + DMCd + DMTe | 7.97 | 1865 | |
| CdTe | DMCd + DMTe | | | |

Table 4-5. Organo Metallic Precursors and Semiconductor Films Grown by MOCVD

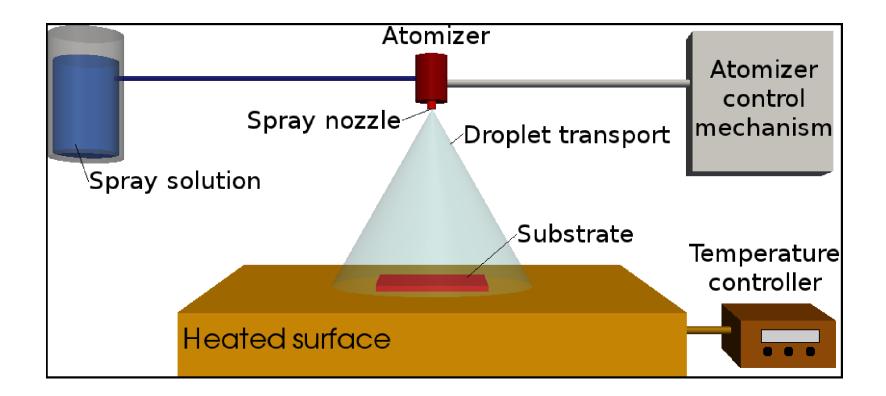
*log P(torr) = a - b/T K

Adapted from Ref. 31.

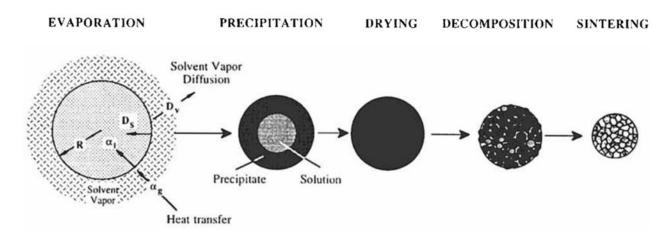
Different materials deposited by MOCVD

Introduction

- Spray deposition is fundamentally work on two major principle atomization or aerogel formation.
- **atomization** is the production of droplets which are dispersion into the gas.
- **aerosol** defined as a suspension of solid or liquid particles in a gas.



Fundamental steps involved in spray deposition technique:



- evaporation evaporation of solvent from the surface, diffusion of solvent vapour away from droplet, change in droplet temperature, diffusion of solute toward the center of the droplet, change in droplet size.
- precipitation/drying involves volume precipitation or surface precipitation of the solute, followed by the evaporation of the solvent through the nanoporous crust
- thermal decomposition or pyrolysis forms a nanoporous structure
- **sintering** involves the adhesion/solidification of the crystallites

fundamentals – precipitation control

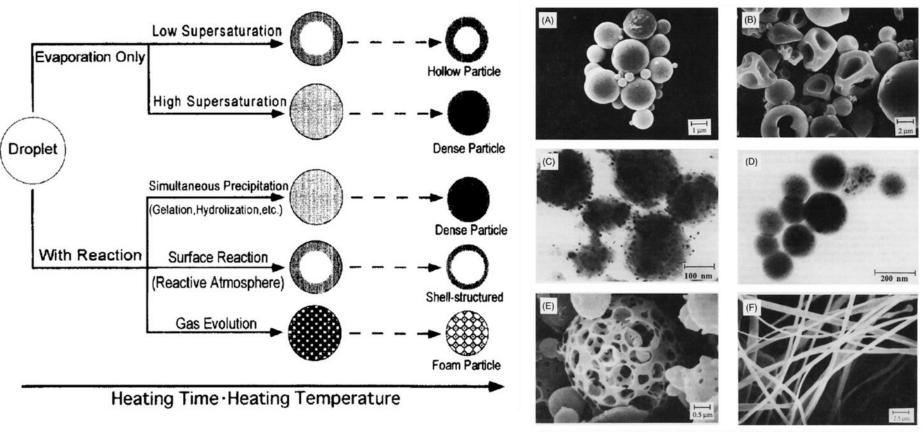


Fig. 3. Various morphologies of particles produced by SP processes: (A) solid ZrO₂ particles derived from 0.1M ZHC solution, (B) irregular ZeO₂ particles derived from 1.M ZAC solution, (C) Al₂O₂/platinum nanocomposite particles derived from 0.4M Al₂SO₃).-1l₂PCQ, solution, (E) catalya particles derived from 0.1M Al₂O₂O₂-platinum nanocomposite particles derived from 0.4M Al₂SO₃).-pl₂PCQ, solution, (E) catalya particles derived from 0.1M NI₄VO₂-H₂PO₄-critic acid solution, and (F) Y₁O₂-stabilized ZeO₄ discontinuous fiber derived from ZAC-6 wt%-PVOH-surfactant solution.

precipitation behavior can be controlled by the solubility of the starting materials or by introducing a precipitation reaction into the droplet

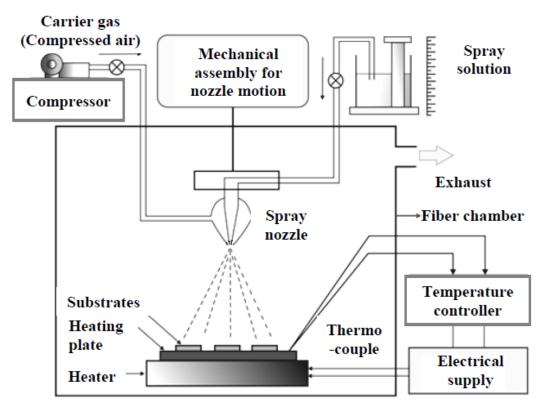
Types of Spray deposition technique:

• According to the way how we are doing atomization or aerogel formation spray technique are classified into

1. Spray pyrolysis technique

- 2. Electrospray deposition technique
- 3. Electrospin deposition technique
- 4. Spray painting.

Spray pyrolysis technique:



- 1. Spray nozzle
- 2. Mechanical assembly for spray nozzle motion
- 3. Spray solution container
- 4. Compressor
- 5. Heater with temperature controller

6. chamber

Spray pyrolysis is the process in which spray nozzle atomizes and sprayed the precursor solution in small droplets on a preheated substrate, wherein the evaporation of solvent solution, thermal decomposition or pyrrolysis takes place and forms uniform thin film.

Factors affecting in spray pyrolysis technique

- Atomization of precursor solution: forms a fine and uniform droplets is the significant step in spray pyrolysis technique. The atomizer forms the droplets with different size, different atomization rate and different velocity. It depends on a) pressure of the carrier gas
 - b) density of spraying solution and
 - c) viscosity of the spraying solution.

• Aerogel transport: the precursor solution is atomized at the nozzle and fine droplet or aerogel is formed which is transported from nozzle to substrate. During transportation following forces affects

a) **gravitational-** pull the droplets downward, droplet size increase gravitation force increases

b) **stokes force-** friction force on droplet in air, droplet size increases stokes force also increases.

c) **thermophorotic force:** this is caused due to thermal gradient, this force repeals the droplets from the hot surface.

- **Decomposition of the precursor:** After arrival of the droplets in the vicinity of substrate several processes takes place such
 - -residual solvent evaporation,
 - -spreading of the droplets over the substrate surface,
 - -decomposition of salt due to thermal energy occur

Following factors play major roll in decomposition;

- a) substrate temperature,
- b) carrier gas flow rate,
- c) distance between nozzle to substrate,
- d) viscosity of the solution,
- e) solution concentration
- f) spraying rate.
- g) chemical composition of the carrier gas
- f) environment in the chember

Steps involved in spray pyrolysis technique:

- Aerosol formation of the droplets at the tip of the nozzle
- Solvent evaporation starts due to the temperature gradient. It forms precipitate during their passage through the temperature gradient from nozzle (low temperature) to substrate (high temperature).
- Pyrolytic decomposition of the precipitate occurs due to the temperature gradient before the precipitate reaches the substrate.
- Pyrolyzed precipitate reaches the substrate. Nucleation and growth of film starts on the surface of substrate.
- With deposition time, film thickness increases.

Advantages:

- Cost effective
- Large area deposition
- Relatively uniform film formation
- No extreme high temperatures required during processing
- Easier to dope films with virtually any elements in any proportion, by merely adding the source of dopant in the spray solution.
- Synthesis of layered films and films with composition gradients throughout the thickness is possible by varying the composition of the spray solution.

Dis-advantages:

- Contamination issue: sometimes byproduct does not decompose completely and trapped inside the film.
- Spray pyrolysis is very effective for oxide film formation but not suitable for metal thin film deposition.